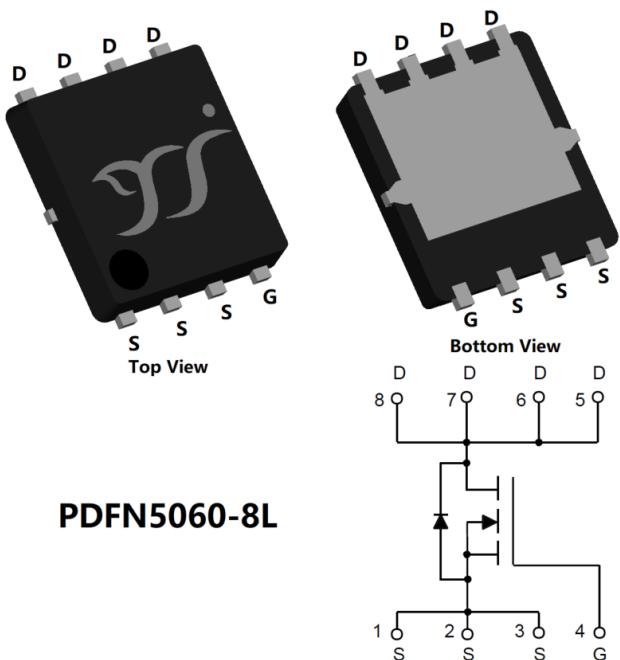




**RoHS**  
COMPLIANT

**YJG200G04BR**

## N-Channel Enhancement Mode Field Effect Transistor



### Product Summary

- $V_{DS}$  40V
- $I_D$  200A
- $R_{DS(ON)}$  (at  $V_{GS}=10V$ )  $<1.3m\Omega$
- $R_{DS(ON)}$  (at  $V_{GS}=4.5V$ )  $<2m\Omega$
- 100% EAS Tested
- 100%  $\nabla V_{DS}$  Tested

### General Description

- Split gate trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low  $R_{DS(ON)}$
- Moisture Sensitivity Level 3
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

### Applications

- Power switching application
- Uninterruptible power supply
- DC-DC convertor

### ■ Absolute Maximum Ratings ( $T_A=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-source Voltage	$V_{DS}$	40	V
Gate-source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current	$I_D$ ( $T_A=25^\circ C$ )	36	A
	$I_D$ ( $T_A=100^\circ C$ )	25	
	$I_D$ ( $T_c=25^\circ C$ )	200	
	$I_D$ ( $T_c=100^\circ C$ )	141	
Pulsed Drain Current <sup>A</sup>	$I_{DM}$	800	A
Avalanche energy <sup>B</sup>	EAS	625	mJ
Total Power Dissipation <sup>C</sup>	$P_D$ ( $T_A=25^\circ C$ )	3.7	W
	$P_D$ ( $T_A=100^\circ C$ )	1.8	
	$P_D$ ( $T_c=25^\circ C$ )	187	
	$P_D$ ( $T_c=100^\circ C$ )	93	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55~+175	°C

### ■ Thermal resistance

Parameter	Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient <sup>D</sup>	$R_{\theta JA}$	35	40	°C/W
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	0.65	0.8	

### ■ Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJG200G04BR	F1	G200G04BR	5000	10000	100000	13" reel



# YJG200G04BR

## ■ Electrical Characteristics ( $T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
<b>Static Parameter</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	40	-	-	V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}}=40\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	$\mu\text{A}$
		$V_{\text{DS}}=40\text{V}, V_{\text{GS}}=0\text{V}, T_J=175^\circ\text{C}$	-	-	100	
Gate-Body Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	$\pm 100$	nA
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.0	1.8	2.5	V
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=100\text{A}$	-	1	1.3	$\text{m}\Omega$
		$V_{\text{GS}}=10\text{V}, I_{\text{D}}=20\text{A}$	-	1	1.3	
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=20\text{A}$	-	1.5	2	
Diode Forward Voltage	$V_{\text{SD}}$	$I_{\text{S}}=100\text{A}, V_{\text{GS}}=0\text{V}$	-	0.9	1.2	V
Gate resistance	$R_{\text{G}}$	$f=1\text{MHz}$	-	1.5	-	$\Omega$
Maximum Body-Diode Continuous Current	$I_{\text{S}}$		-	-	200	A
<b>Dynamic Parameters</b>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	7400	-	$\text{pF}$
Output Capacitance	$C_{\text{oss}}$		-	1340	-	
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	70	-	
<b>Switching Parameters</b>						
Total Gate Charge	$Q_{\text{g}}$	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=20\text{V}, I_{\text{D}}=100\text{A}$	-	126	-	$\text{nC}$
Gate-Source Charge	$Q_{\text{gs}}$		-	21	-	
Gate-Drain Charge	$Q_{\text{gd}}$		-	38	-	
Reverse Recovery Charge	$Q_{\text{rr}}$	$I_{\text{F}}=100\text{A}, \text{di/dt}=100\text{A}/\mu\text{s}$	-	150	-	$\text{nC}$
Reverse Recovery Time	$t_{\text{rr}}$		-	82	-	$\text{ns}$
Turn-on Delay Time	$t_{\text{D}(\text{on})}$		-	24	-	$\text{ns}$
Turn-on Rise Time	$t_{\text{r}}$	$V_{\text{GS}}=10\text{V}, V_{\text{DD}}=20\text{V}, I_{\text{D}}=100\text{A}$ $R_{\text{GEN}}=2.2\Omega$	-	276	-	
Turn-off Delay Time	$t_{\text{D}(\text{off})}$		-	49	-	
Turn-off fall Time	$t_{\text{f}}$		-	22	-	

- A. Repetitive rating; pulse width limited by max. junction temperature.
- B.  $T_J=25^\circ\text{C}, V_{\text{DD}}=30\text{V}, V_{\text{G}}=10\text{V}, R_{\text{G}}=25\Omega, L=0.5\text{mH}, I_{\text{AS}}=50\text{A}$ .
- C.  $P_d$  is based on max. junction temperature, using junction-case thermal resistance.
- D. The value of  $R_{\text{0JA}}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in the still air environment with  $T_A=25^\circ\text{C}$ . The maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.

## ■ Typical Electrical and Thermal Characteristics Diagrams

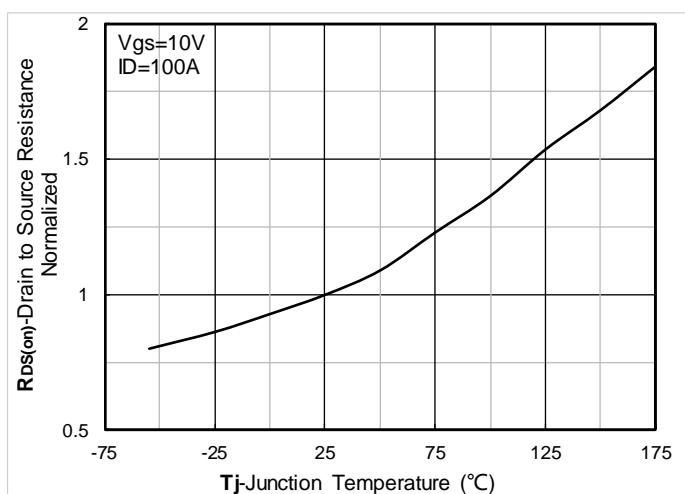
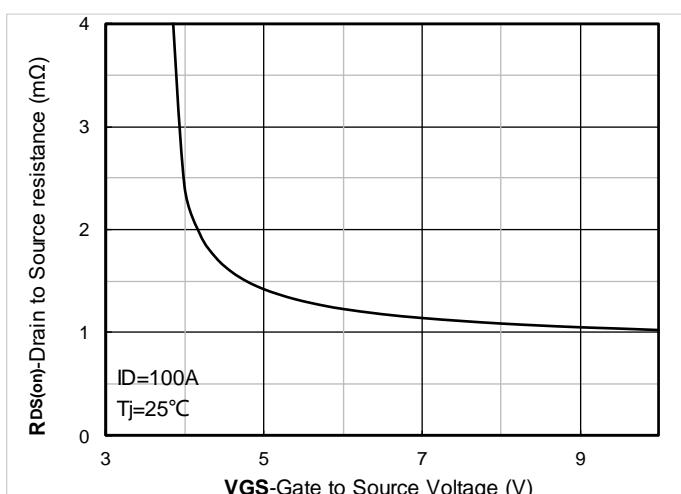
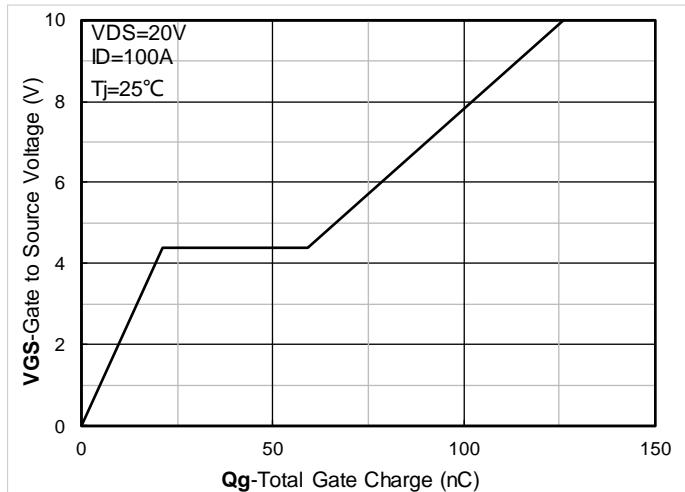
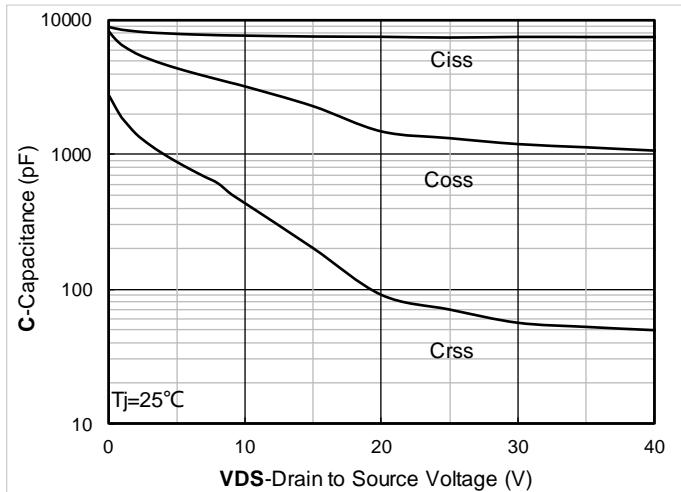
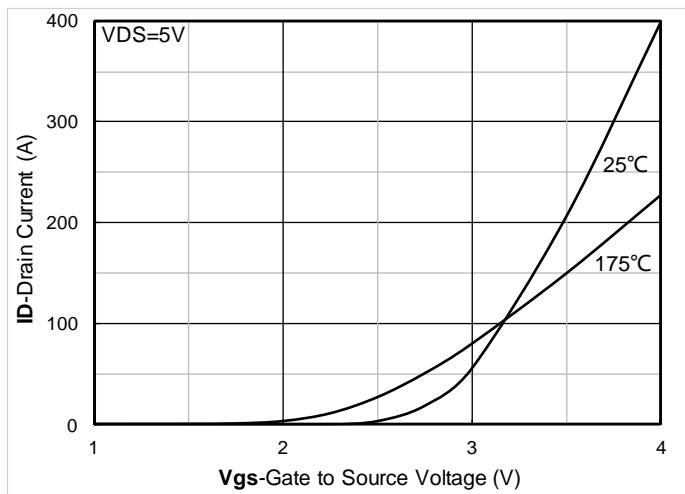
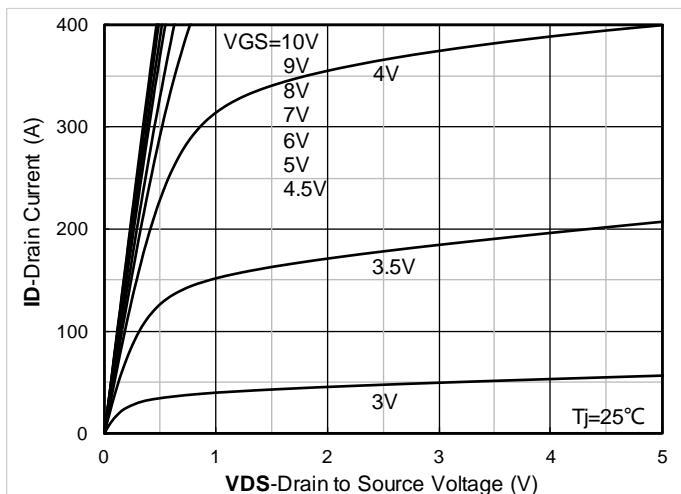


Figure 5. On-Resistance vs Gate to Source Voltage

Figure 6. Normalized On-Resistance

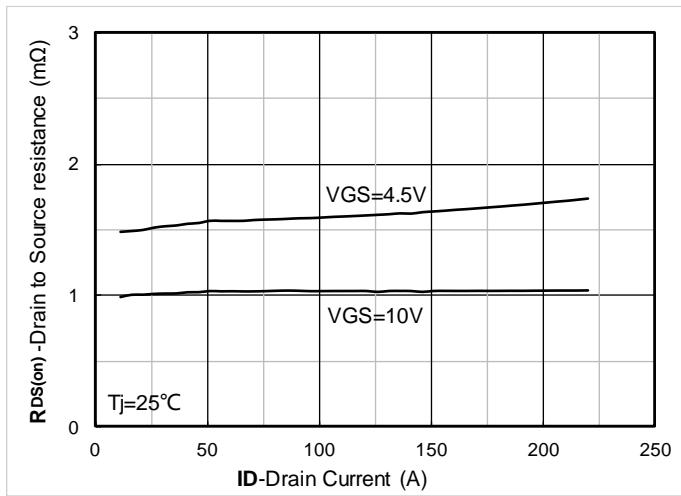


Figure 7. RDS(on) VS Drain Current

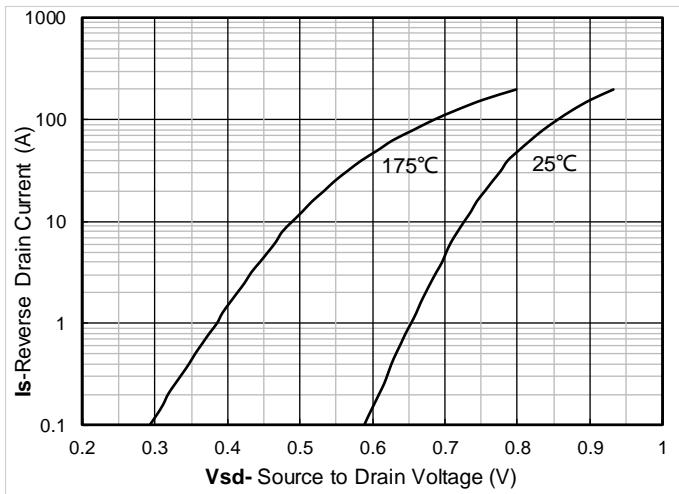


Figure 8. Forward characteristics of reverse diode

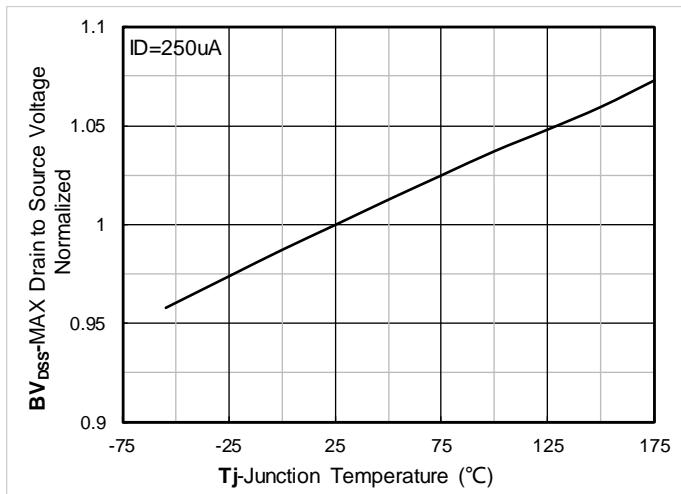


Figure 9. Normalized breakdown voltage

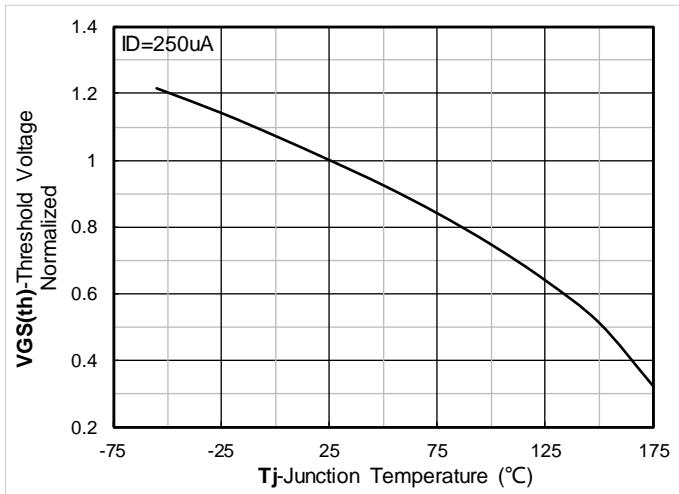


Figure 10. Normalized Threshold voltage

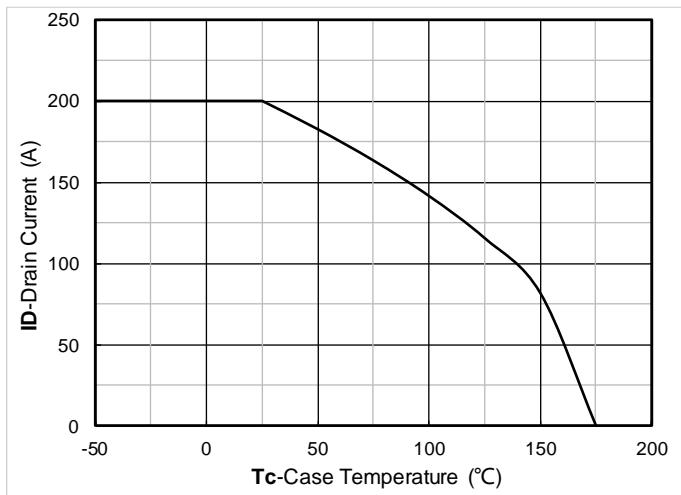


Figure 11. Current dissipation

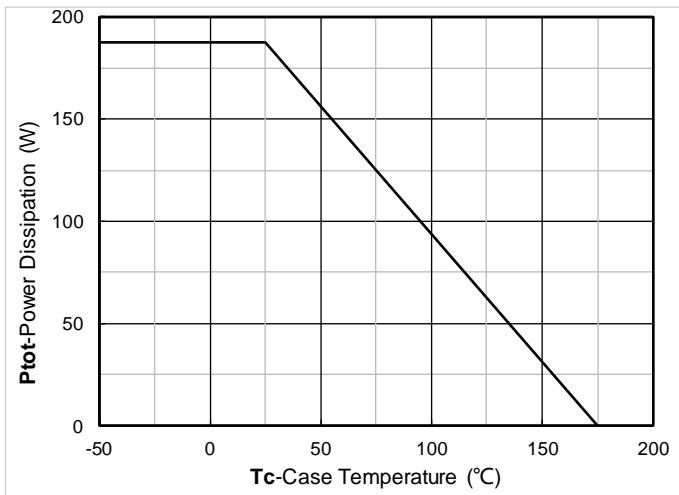


Figure 12. Power dissipation

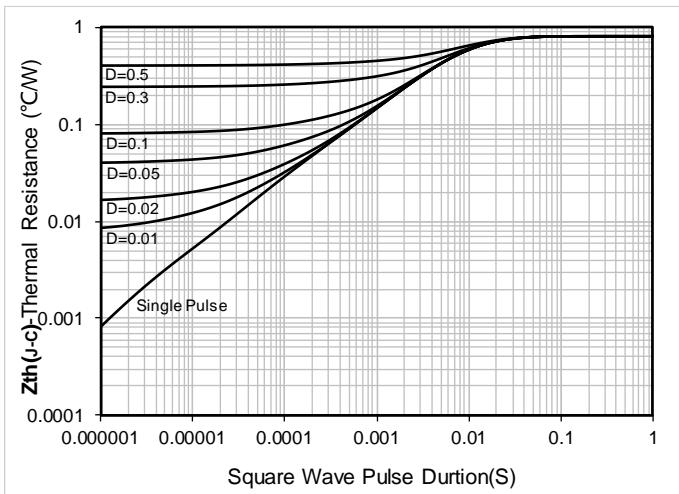


Figure 13. Maximum Transient Thermal Impedance

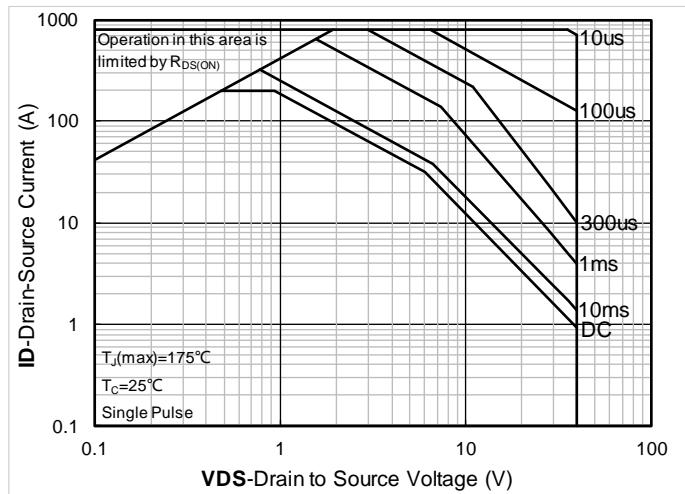


Figure 14. Safe Operation Area

## ■ Test Circuits & Waveforms

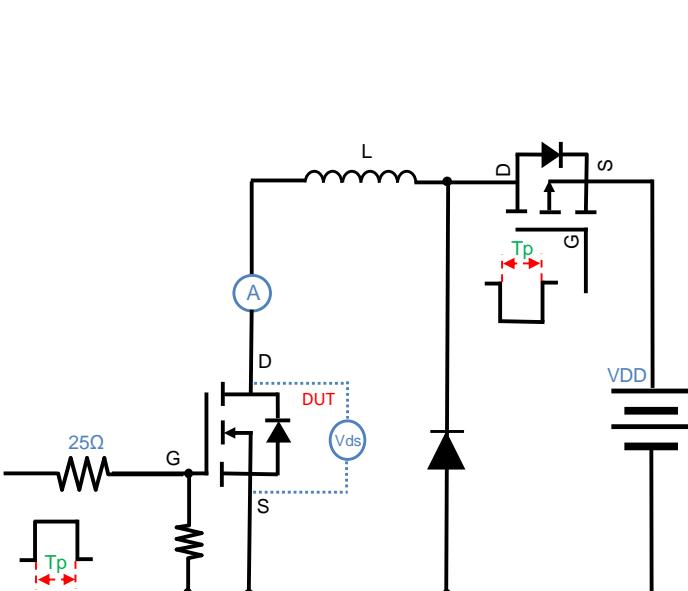
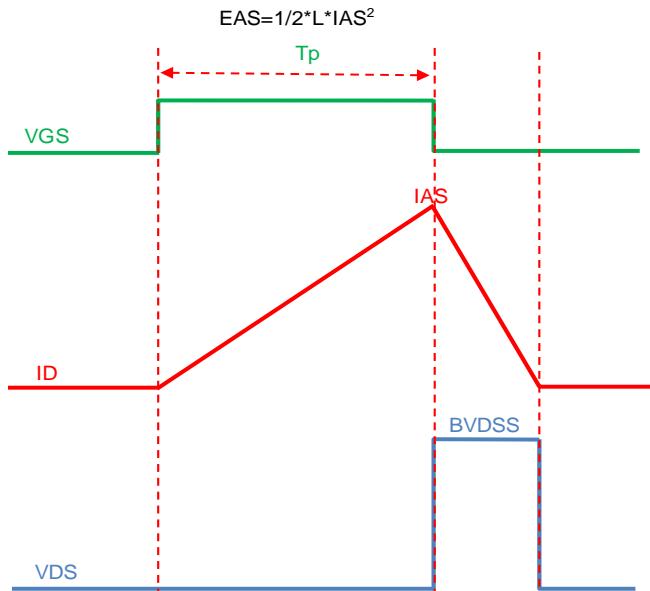


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform



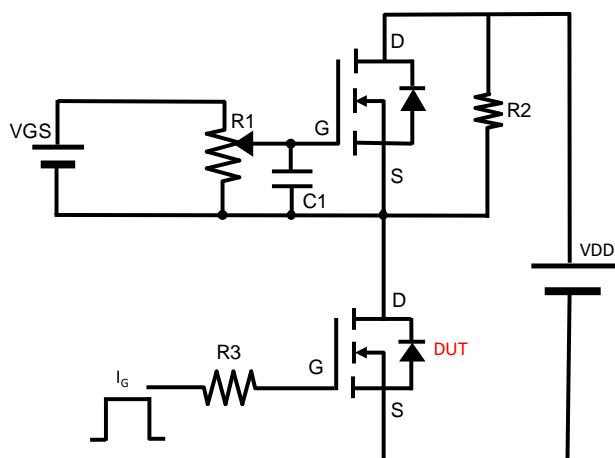


Figure B. Gate Charge Test Circuit & Waveform

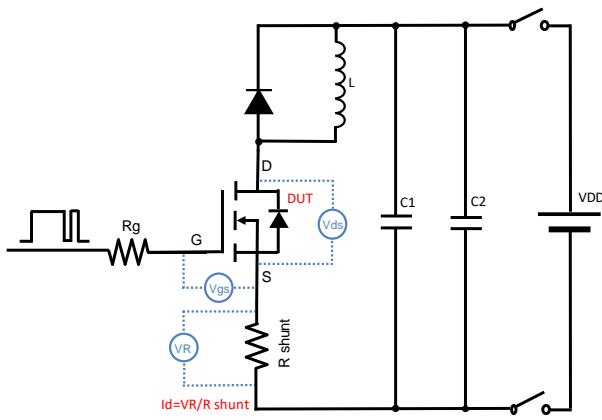
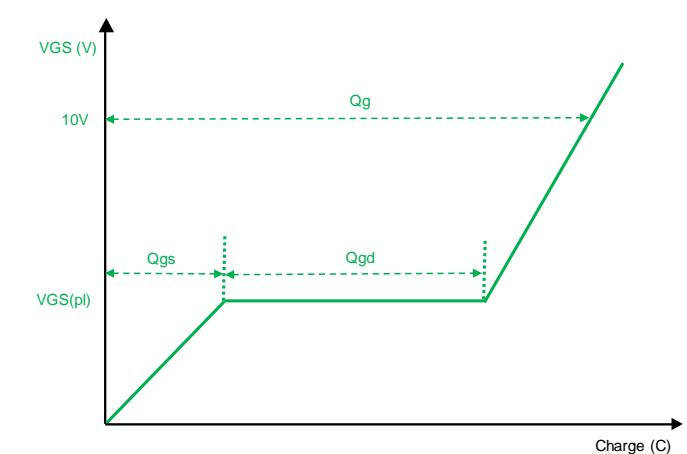


Figure C. Resistive Switching Test Circuit & Waveform

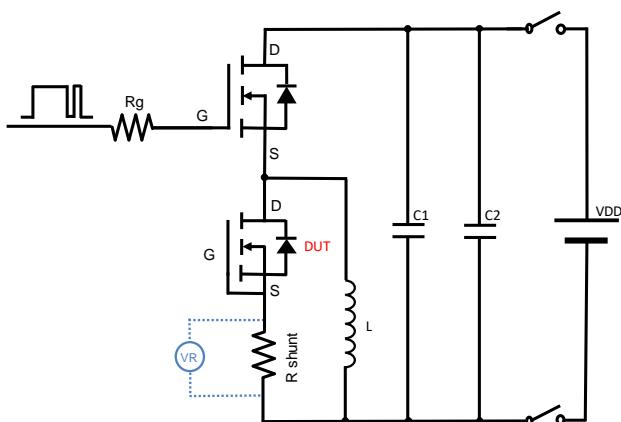
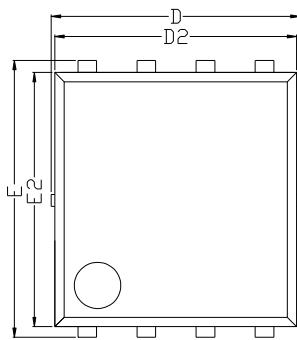
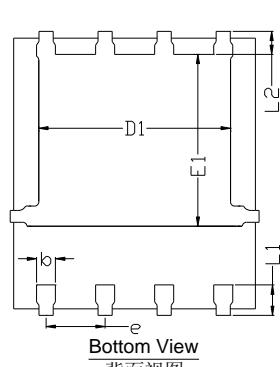
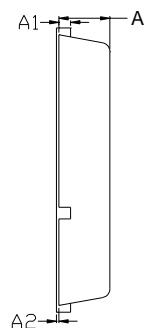
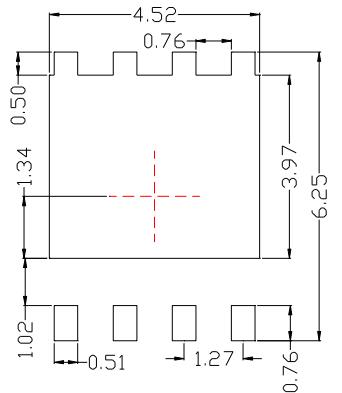


Figure D. Diode Recovery Test Circuit & Waveform



## ■ PDFN5060-8L-D-0.95mm Package information

Top View  
正面视图Bottom View  
背面视图Side View  
侧面视图Suggested Solder Pad Layout  
Top View

Note:  
1. Controlling dimension in millimeters.  
2. General tolerance:  $\pm 0.10\text{mm}$ .  
3. The pad layout is for reference purposes only.

SYMBOL	MILLIMETER		
	MIN	NOM	MAX
D	5.15	5.35	5.55
E	5.95	6.05	6.15
A	0.85	0.95	1.00
A1	0.203	BSC	
A2			0.08
D1	4.25	4.35	4.45
E1	3.525	3.625	3.725
D2		5.20	
E2		5.55	
L1	0.45	0.55	0.65
L2	0.68	BSC	
b	0.3	0.4	0.5
e	1.27	BSC	



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